

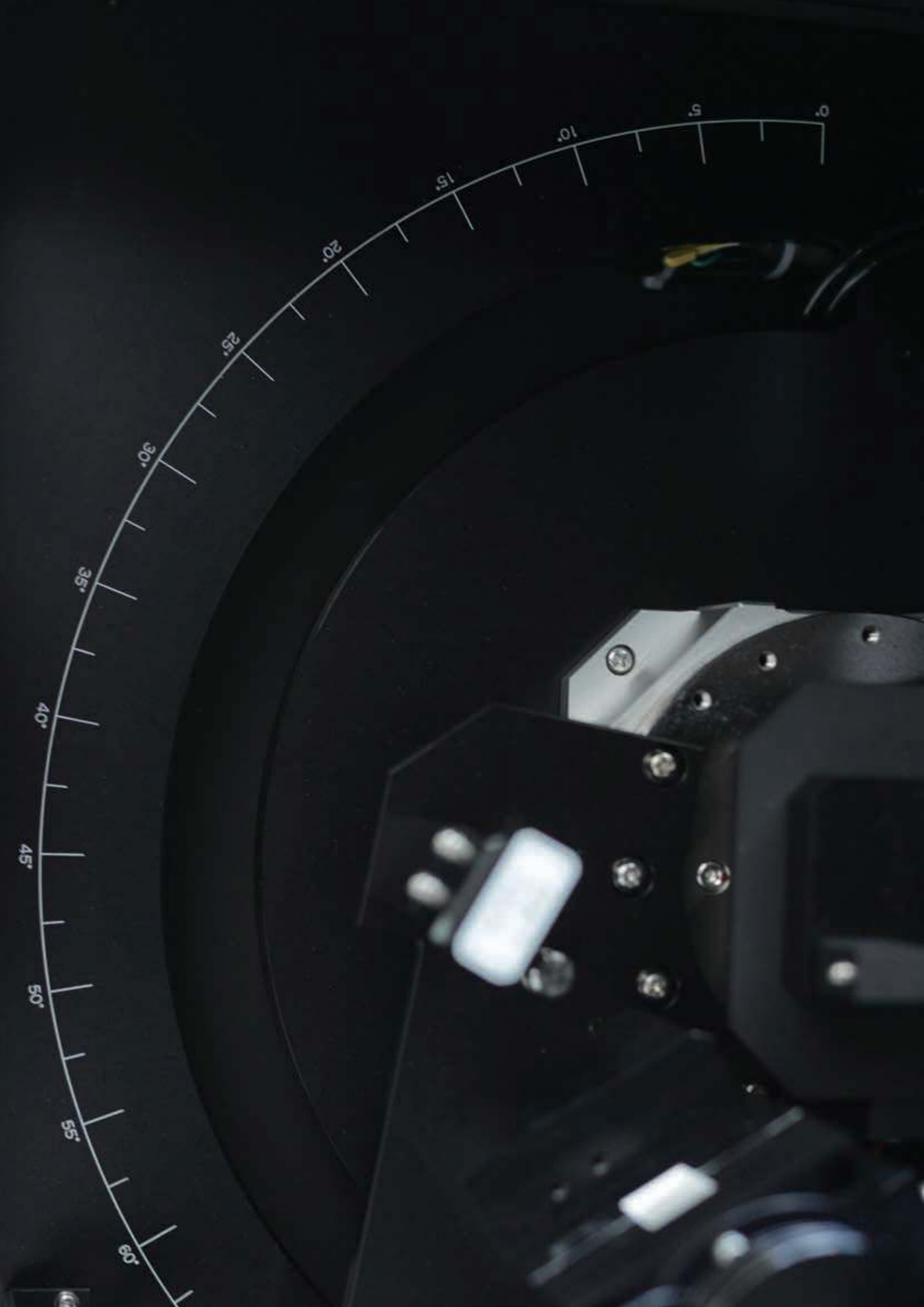
UV-Visible/NIR Spectrophotometers

V-700 Series



JASCO

Performance
Innovation
Reliability



For scientists performing spectral characterization, thermodynamic studies, and quantitative measurements for advanced bio- and materials research, who need confidence in the accuracy and reproducibility of their measurements and rely on the results. The V-700 Series UV-Visible/NIR spectrophotometers provides an excellent optical system with wide wavelength range for a diverse array of applications.

The V-700 Series comprises five distinct models covering the entire spectrum from the far-UV (187 nm) to the near-IR (3200 nm). The compact optical design of the V-700 Series of UV-Visible spectrophotometers significantly reduces the requirement for bench space in the modern laboratory.

Table of Contents

Instrument and Systems	
Instrument Features	4
Accessories and Applications	
Temperature Control	10
Ambient Accessories	13
Micro Volume	14
Optical Fiber Units	15
Integrating Spheres	16
Absolute Reflectance	18
Specular Reflectance	19
Autosampler, Sippers & Flow Cells	20
Software and Accessories	
Spectra Manager™	22
Standard Measurement Programs	24
Optional Software	26
iRM-1000	30
Specifications	31

Common Features of the V-700 Series



Compact Design

The compact design of the V-700 Series of UV-visible spectrophotometers significantly reduces the requirement for bench space in the modern laboratory.

Wide Wavelength Range

High energy throughput provides excellent signal-to-noise ratio for the entire UV-visible to NIR spectral range, with detectors selected for the highest sensitivity and dynamic range.

Excellent Optical Performance

Sophisticated electronic and optical design reduces noise and stray light for highly accurate measurements over wide wavelength and photometric ranges.

High Speed Scanning

High throughput optics and fast response detectors provide fast scanning without wavelength tracking errors.

Dark Correction

Stray light reduction features that enable accurate measurement of strongly absorbing samples.

Monochromator Step Scanning

Step scan provides reliable peak assignment to samples with narrow peak widths.

User-Friendly Operation

Spectra Manager™ Suite for Windows and iRM hand-held controller for comprehensive control, acquisition and data processing. 21 CFR part 11 compliance is available for PC.

Wide Range of Accessories and Applications software

A comprehensive selection of over 50 sampling accessories for gas, liquid and solid samples for many different applications, with matching dedicated application programs. IQ Accessory automatically recognizes the connected accessory and selects a matching measurement program.

IQ Start

For routine operation a measurement can be made from a simple push of the 'Start Button', great for speeding up measurement, and for multiple users.

Regulatory Compliance

All models can be used in GxP compliant laboratories, a comprehensive validation to USP, EP and JP is included as standard. Installation and Operational Qualification (IQ, OQ) are available for installation and maintenance.

V-730 UV-Visible Spectrophotometer

The V-730 is a general-purpose double-beam spectrophotometer with a compact space-saving design. Its excellent spectroscopic performance is suitable for routine QC, teaching and research applications.

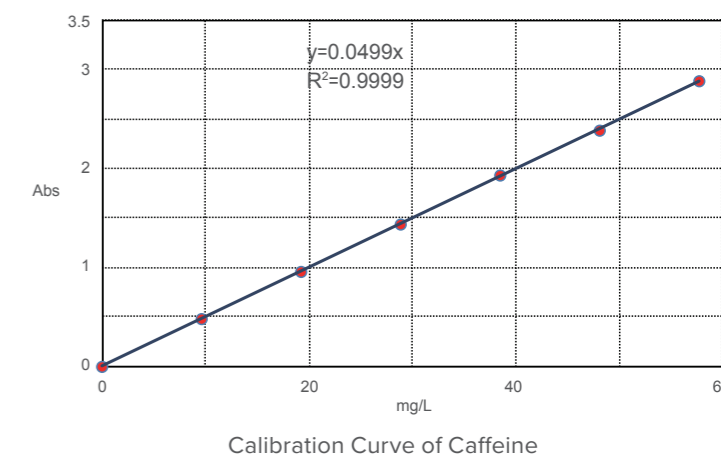
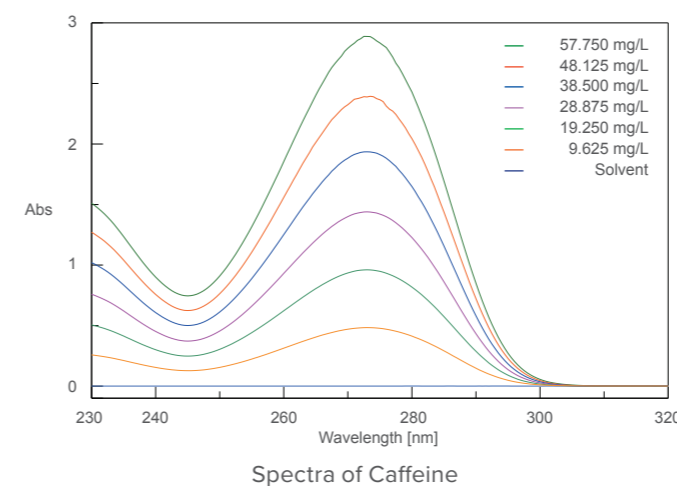


System Features

- Double-beam spectrophotometer with single monochromator and silicon photodiode detectors
- Compact with dimensions of only 440 (W) x 470 (D) x 215 (H) mm.
- Wide wavelength range – 190 to 1100 nm
- Fixed spectral bandwidth 1.0 nm for high resolution measurement
- High-speed scanning up to 8,000 nm/min
- Stray light 0.02% for exceptional absorbance linearity up to 3Abs

Performance and Application

With an optimal balance between light intensity, signal to noise and resolution, with fast response and rapid monochromator slew speed, the V-730 can be used with a wide range of sampling accessories and optional programs for a broad range of analyses.



V-730BIO for Life Sciences

The dedicated V-730BIO has been designed specifically for applications in Life Sciences. Comprising a V-730, with either Spectra Manager™ or an intelligent Remote Module (iRM) for biological and clinical analysis, and a micro cell holder. Bio-analytical application programs included are: protein/nucleic acid measurement, temperature ramping/DNA melting analysis, kinetics measurement with advanced analysis, and quantitative protein analysis with six different calibration methods.

V-750 UV-Visible Spectrophotometer

High resolution UV-Visible spectrophotometer with double-beam, single monochromator.

The V-750 UV-Visible spectrophotometer includes a precision double-beam optical system with variable spectral bandwidth. A high sensitivity PMT detector provides accurate and reproducible measurements for low to high absorbing samples. By controlling the high voltage applied to the PMT, the dynode feedback offers a wider dynamic range than is generally found in UV-Visible spectrophotometers. For high resolution measurements, such as gas and vapor phase spectroscopy, the spectral bandwidth can be set as narrow as 0.1 nm. Special low stray light slit settings which optimize the light image on the grating provide increased linearity to up to 4 absorbance units.



System Features

- Double-beam spectrophotometer with single monochromator
- High sensitivity PMT detector
- Wide wavelength range – 190 to 900 nm
- Variable spectral bandwidth
- High-speed scanning up to 4,000 nm/min (Scanning speed in Preview Mode is 8,000 nm/min)
- Stray light 0.005%

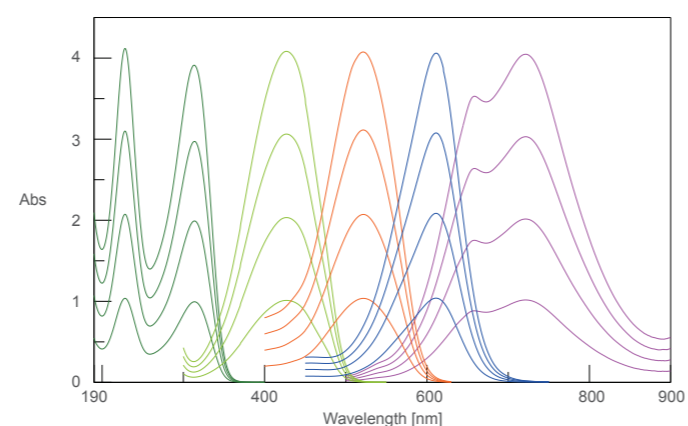
Absorbance Linearity to Greater than 4 Abs Across a Wide Wavelength Range

The photometric linearity range is up to 4 Abs in the UV-Visible region (and up to 5 Abs in the visible region*). The V-750 offers measurement with a wide dynamic range and high absorbance by employing optimized high-order cut-off filters, ultra high-resolution A/D converter and simplified signal processing prior to the A/D conversion.

*Measurement of KMnO₄ solution.

Performance and Application

The V-750 can be used with any absorbance, transmittance or reflectance measurements in the UV-visible region, including liquids, solids and with options for specular, absolute and diffuse reflectance.



Spectra of Various Solutions measured by V-750 (Green: Ranitidine hydrochloride, Yellow: Aluminium Lake, Orange: Amaranth, Blue: Indigocarmine, Pink: NiSO₄)

V-760 UV-Visible Spectrophotometer

High resolution UV-Visible double-beam spectrophotometer with double monochromator for Photometric Linearity to greater than 6 Abs.



The V-760 double beam, double monochromator optical design with lowest stray light (0.00008 %) offers high absorbance linearity across the entire photometric range. The V-760 can measure up to 6 Abs in the UV-Visible region (and up to 8 Abs in the visible region*). Variable spectral band width can be set down to 0.1 nm with special height slits to further reduce stray light and absorbance linearity is made even higher with rear beam attenuation.

*Measurement of KMnO₄ solution.

System Features

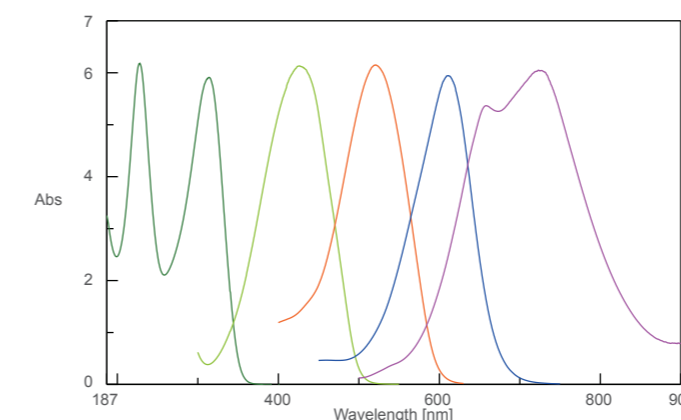
- Double-beam spectrophotometer with double monochromator
- High sensitivity PMT detector
- Wide wavelength range – 187 to 900 nm
- Variable spectral bandwidth
- Low stray light 0.00008 %
- High-speed scanning up to 4,000 nm/min (Scanning speed in Preview Mode is 8,000 nm/min)

Performance and Application

The V-760 is typically used where higher linear dynamic range is required for measurement of most absorbance, transmittance or reflectance in the UV-visible region, including liquids, solids and with options for specular absolute and diffuse reflectance.

Step-Scan Measurement

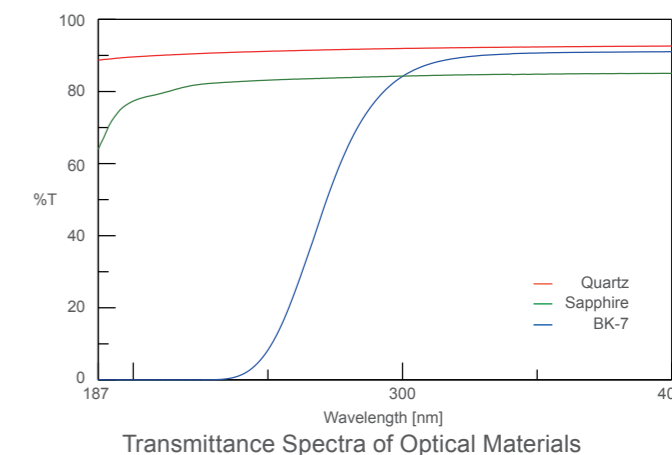
Step-scan is useful for accurate measurement of samples such as bandpass filters for which the transmittance changes significantly over a relatively narrow wavelength range.



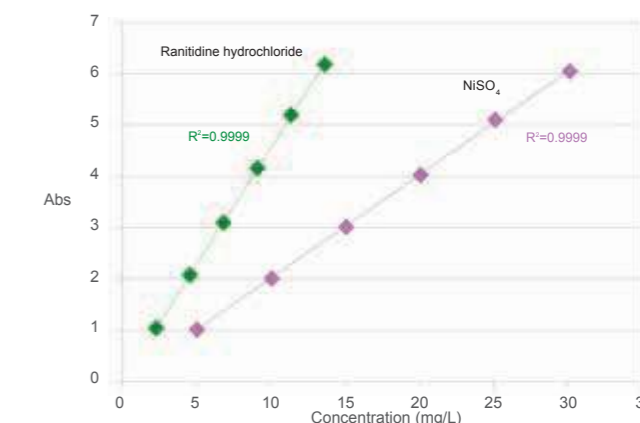
Spectra of Various Solutions measured by V-760 (Green: Ranitidine hydrochloride, Yellow: Aluminium Lake, Orange: Amaranth, Blue: Indigocarmine, Pink: NiSO₄)

Measurement in the Far UV to 187 nm

The lower stray light optical design enables measurement in the UV down to 187 nm without N₂ purging. The transmittance spectra of three optical materials - quartz, sapphire and BK-7 measured using the FLH-741 film holder are shown below.



Transmittance Spectra of Optical Materials



Calibration Curves of Ranitidine Hydrochloride and NiSO₄

V-770 UV-Visible/NIR Spectrophotometer

Single monochromator, dual gratings and PbS detector for wide wavelength in the NIR region up to 3200 nm.

The V-770 offers the unique benefit of single monochromator for higher optical throughput compared to double monochromated systems. This is especially useful for diffuse and specular reflectance measurements in the NIR where signal to noise can be a problem.



System Features

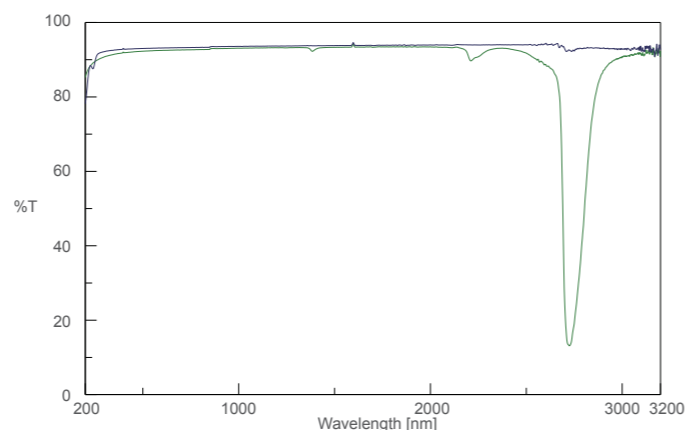
- Double-beam spectrophotometer with single monochromator
- High sensitivity PMT and PbS detectors
- UV-Visible and NIR optimized gratings
- Wide wavelength range PbS detector
- Wide wavelength range – 190 to 2700 nm (3200 nm as option)
- Variable spectral bandwidth
- High-speed scanning up to 4,000 nm/min (Scanning speed in Preview Mode is 8,000 nm/min)
- Stray light 0.005% (UV-visible) to 0.04% and 0.1% (NIR)

Performance and Application

The V-770 can be used with most absorbance, transmittance or reflectance measurement in the UV-visible to NIR region, including liquids, solids and with options for specular absolute and diffuse reflectance.

Wide Wavelength Range

The V-770 uses a combination of wide range monochromator, PbS detector and anhydrous windows to cover the wavelength range to 3200nm. The high optical throughput of a single monochromator design provides excellent signal to noise when measuring transmission, diffuse and absolute reflectance to longer wavelengths.



The NIR UV-Visible spectra shows the water band in a quartz substrate (Blue) compared to anhydrous quartz (Green).

V-780 UV-Visible/NIR Spectrophotometer

Single monochromator, dual gratings and InGaAs detector for enhanced sensitivity in the NIR region up to 1600 nm.

The V-780 has the same unique benefit as the V-770 of a single monochromator for higher optical throughput, but also has improved sensitivity from the InGaAs detector with better response in the NIR.



System Features

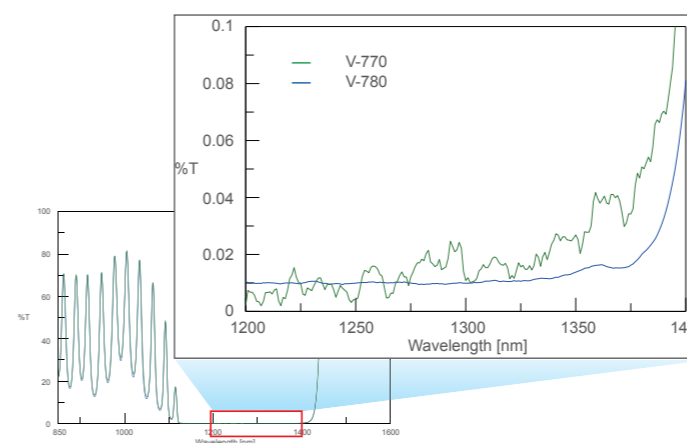
- Double-beam spectrophotometer with single monochromator
- High sensitivity PMT and InGaAs detectors
- UV-Visible and NIR optimized gratings
- Wide wavelength range – 190 to 1600 nm
- Variable spectral bandwidth
- High-speed scanning up to 4,000 nm/min (Scanning speed in Preview Mode is 8,000 nm/min)
- Stray light 0.005% (UV-visible) to 0.04% (NIR)

Performance and Application

The V-780 can be used with most absorbance, transmittance or reflectance measurements in the UV-visible to NIR region, including liquids, solids and with options for specular, absolute and diffuse reflectance in a narrower wavelength range than the V-770 but with higher sensitivity.

High Sensitivity

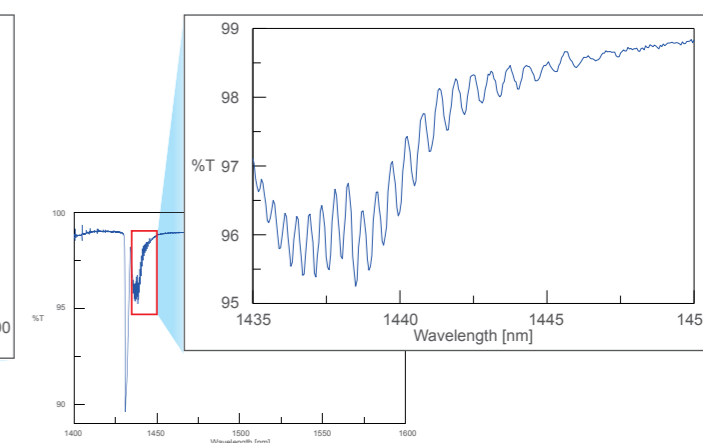
The figure (below) compares a 1.3 μm band cutoff filter for optical communication measured using the V-770 with a Peltier-cooled PbS photo-conductive detector and the V-780 with a Peltier-cooled InGaAs photodiode detector. The V-780 offers significantly increased S/N.



Spectra of 1.3 μm Cut-Off Filter

High Resolution

The figures (below) show the vibrational NIR spectrum of CO₂ gas (pathlength: 100 mm), measured using the V-780. Overtones are seen near 1430 nm. Zooming in shows that the V-780 has excellent resolution for observing the rotational peaks in the vibrational spectrum.



Transmittance Spectrum of CO₂ Gas Sample (long term accumulation)

Temperature Control

Automatic Peltier Multi-Cell Holders

PSC-763 | 6-Position (Air-Cooled)

PAC-743 | 6 or 8-Position (Water-Cooled)

PAC-743R | 6 or 8-Position (Water-Cooled, Thermostatted Reference)

Specifications

Model	PSC-763	PAC-743	PAC-743R
Compatible Cells	Rectangular cells: 10x10, 2x10, 4x10 mm	Please refer to the "PAC-743/743R Cell Accessory Specifications"	
Reference	Rectangular cells: 10x10, 2x10, 4x10 mm (1 pc)		
Temperature Control System	Heating/cooling system with Peltier effect (PAC-743R includes temperature controlled reference cell)		
Heat Radiating System	Air cooled	Water cooled	
Stirring System	Integrated variable speed magnetic stirrer (10 x 10 mm cell)	Please refer to the "PAC-743/743R Cell Accessory Specifications"	
Temperature Setting Range	10 to 70°C	-10 to 110°C	
Temperature Control Range	15 to 60°C (at 20°C)	0 to 100°C (at 20°C)	
Temperature Setting Precision	±0.1°C (cell holder sensor)	±0.1°C	
Temperature Accuracy	With cell holder sensor: ±0.5°C (20 to 40°C), ±1°C (other temp range)		



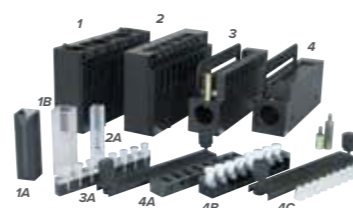
PSC-763



PAC-743
PAC-743R

PAC-743/743R Cell Accessory Specifications

Cell Block Number	Cell Block	Compatible Cells	Cell Number	In Cell Sensor
1	6-position	Rectangular quartz cell: 2x10 mm	1A	6916-H516A Sensor in cell, 1 pc 6916-H517A Sensor in cell, 6 pcs
		Rectangular quartz cell: 4x10 mm	-	
		Rectangular quartz cell: 10x10 mm (integrated variable speed magnetic stirrer)	1B	
		Capillary cell adapter and cell (sealing compound required) *Customized items	-	
2	8-position	Rectangular quartz cell: 5x5 mm (integrated variable speed magnetic stirrer)	2A	6916-H516A Sensor in cell, 1 pc 6916-H518A Sensor in cell, 8 pcs
3	1 mm 8-position micro (stirrer function not available)	2x1 mm (10 µL), Silicon cap kit: 8 silicon caps, 1 silicon cap with sensor hole, cap fixture	3A	6916-H516A Sensor in cell, 1 pc *8th cell position only monitor cell block temp
4	10 mm 8-position micro (stirrer function not available)	2x10 mm (10 µL), no well cap	4A	6916-H516A Sensor in cell, 1 pc *8th cell position only monitor cell block temp
		2x10 mm (10 µL), Teflon caps	4B	
		Silicon cap kit: 8 silicon caps, 1 silicon cap with sensor hole, cap fixture	4C	



Peltier Thermostatted Single Cell Holders

EHCS-760 | Single Position Cuvette (Air-Cooled)

ETCS-761 | Single Position Cuvette (Water-Cooled)

ETCR-762 | Single Position Cuvette (Water-Cooled, Thermostatted Reference)

Specifications

Model	EHCS-760	ETCS-761	ETCR-762
Compatible Cells	Rectangular cell, 10 x 10, 2 or 4 x 10mm, 1 pc		
Temperature Control	Sample Only		Sample and Reference
	Heating/Cooling system using Peltier effect		
Heat Radiating System	Air-Cooled	Water-Cooled	
Stirring System	Integrated variable speed magnetic stirrer (10 x 10 mm cell)		
Temperature Setting Range	5 to 70°C	-10 to 110°C	-10 to 110°C
Temperature Control Range	10 to 60°C (at 25°C)	0 to 100°C (for cooling water temperature at 20°C)	
Temperature Control Accuracy	±0.1°C (cell holder sensor)		
Temperature Accuracy	With cell holder sensor: ±0.5°C (20°C to 40°C), ±1°C (other temp. range) With optional temp. sensor: ±0.2°C		



EHCS-760



ETCS-761



ETCR-762

Options

Cell Mask Kit	Sample Masks and cell-height adjustment for the cell position (a 2 mm path width micro cell can be used to measure sample with a min. 100 µL volume).
OPS-515	Optional sensor used to monitor the temperature inside the sample cell.
Cell Spacers	For cells with an optical path length of 1, 2 and 5 mm. (P/N: 6939-0501PA for 2 mm cell, 6916-6018PA for 2 mm cell and 6916-6019PA for 5 mm cell)
Capillary Adapter	For V-730/V-730BIO only Used for a capillary cell (minimum sample volume of 3 µL). The optional sensor (OPS-515) in the cell adapter is required for temperature monitoring. (P/N: 6916-H360A Capillary Adapter)

used only with V-730 **V-730**

used only with V-730BIO **V-730BIO**

used only with V-750 **V-750**

used only with V-760 **V-760**

used only with V-770 **V-770**

used only with V-780 **V-780**

compatible with all V-700 Series instruments **V-700**

Temperature Control

Constant Temperature Cell Holders/Cell Changers

The following cell holders can be used with water circulators for maintaining samples at a constant temperature.

STR-773 | Water Thermostatted Cell Holder with Stirrer

HMC-711 | Water Thermostatted Micro Cell Holder

MHT-745 | Manual 4-Position Water Thermostatted Turret Cell Holder

NCP-706 | Automatic 6-Position Water Thermostatted Cell Changer

Specifications

Model	STR-773	HMC-711	MHT-745	NCP-706
Compatible Cells	Rectangular cells: 10x10, 4x10, 2x10 mm	Rectangular cells: 10x10, 10x5, 2x10, 4x10, 2x5 mm (50 µL minimum sample volume)	Rectangular cells: 10x10, 4x10, 2x10 mm	Rectangular cells: 10x10, 4x10, 2x10 mm
Temperature Control	Thermostatted water circulation for sample and reference			
Operating Temperature	10 to 90°C			
Additional	Integrated variable speed magnetic stirrer (2 mm micro cell cannot be used with the stirrer)	Mask for 100 mL cell (2x10 mm), 200 mL cell (4x10 mm)	--	Cell switching software controlled



STR-773



HMC-711



MHT-745



NCP-706

Other Temperature Control Accessories

CTU-100 | Mini Circulating Water Bath

Specifications

Temperature Control Range	Room Temperature -10 to 40°C
Temperature Interval	0.1 °C
Bath Volume	Approx. 100 mL
Temperature Sensor/Control Accuracy	±0.2°C / ±0.5°C (at 20°C)
Dimensions	170 (W) x 200 (H) x 311 (D) mm



CTU-100

CSP-909 | Optional Sample Compartment Lid with Syringe Port

Used for fast reaction to inject a reaction initiator into the cuvette without opening the sample chamber lid. Can only be used with a 10x10 mm rectangular cell and requires a syringe with 2 inch (50 mm) needle.

Compatible with the following cell holders: STR-773, EHCS-760, ETCS-761, ETCR-762



CSP-909

Ambient Accessories

- used only with V-730 **V-730**
- used only with V-730BIO **V-730BIO**
- used only with V-750 **V-750**
- used only with V-760 **V-760**
- used only with V-770 **V-770**
- used only with V-780 **V-780**
- compatible with all V-700 Series instruments **V-700**

Liquid and Film Cell Holders/Cell Changers

LSE-701 | Long Path Cell Holder

FSE-702 | 4-Position Manual Long Path Cell Changer

SSE-704 | 6-Position Manual Cell Changer

NCP-705 | 6-Position Automatic Cell Changer

CYH-708 | Cylindrical Cell Holder

Specifications

Model	LSE-701	FSE-702	SSE-704	NCP-705	CYH-708
Compatible Cells	Rectangular cell, pathlength 10, 20, 50 or 100 mm, 1 pc	Rectangular cell, pathlength 10, 20, 50 or 100 mm, 4 pcs	Rectangular cell, pathlength 10 or 20 mm, 6 pcs	Rectangular cell, pathlength 10 mm, 6 sample positions	Cylindrical cells, Φ22 or 30mm pathlength 10, 20, 50 or 100 mm, 1 pc
Reference	Rectangular cell, pathlength 10, 20, 50 or 100 mm, 1 pc	Rectangular cell, pathlength 10, 20, 50 or 100 mm, 1 pc	Rectangular cell, pathlength 10 or 20 mm, 1 pc	Rectangular cell, pathlength 10 mm, 1 pc	Cylindrical cells, Φ22 or 30mm pathlength 10, 20, 50 or 100 mm, 1 pc

FLH-740/FLH-741 | Film Holder

Used to measure the transmittance of solid and transparent samples such as films, plate glass, and filters.

Specifications

Model	FLH-740	FLH-741
Minimum Sample Size	15 (H) x 15 (W) x 0.5 (t) mm	5 (H) x 5 (W) x 0.5 (t) mm
Maximum Sample Size	80 (H) x 100 (W) x 10 (t) mm	80 (H) x 100 (W) x 25 (t) mm

RSH-744 | Rotary Sample Holder

Used to measure a film (planar) sample, which can be rotated 360° around the optical axis and the inclination/tilt of the sample versus the source beam can be varied within a range of ±50°.

Specifications

Model	RSH-744
Minimum Sample Size	10 (H) x 30 (W) x 1 (t) mm
Maximum Sample Size	18 (H) x 38 (W) x 2 (t) mm
Angle of Rotation	Optical axis: 360°, Perpendicular to the optical axis: ±50°

VTA-752 | Film Holder (Variable Incident Angle)

Used to measure transmittance of a film-like sample when the incident angle of the light beam is varied. This incident angle can be set in 1° increments with a rotation range of ±90°.

Specifications

Model	VTA-752
Minimum Sample Size	15 (H) x 35 (W) x 1 (t) mm
Maximum Sample Size	80 (H) x 70 (W) x 2 (t) mm
Range of Rotation Angle	±90°C



LSE-701



FSE-702



SSE-704



NCP-705



CYH-708



FLH-740



FLH-741



RSH-744



VTA-752

Micro Volume

Micro-Volume Liquid Transmission Cell Holders

UCB-710 | Rectangular Cell Holder

With adjustable height and mask for use with 100 μ L micro cells. (50 μ L as an option)



UCB-710

SAH-769 | One Drop Measurement Unit

For high-speed measurement of micro-volumes of proteins and nucleic acids. 1 mm and 0.2 mm pathlengths with sample volumes of 5 and 0.6 μ L, respectively.



SAH-769

EMC-709 | Micro Cell Holder

Used with a 50 or 5 μ L micro cells with an optional spacer.



50 μ L Micro Cell



5 μ L Micro Cell Spacer



EMC-709

EMC-759 | Ultra-Micro Cell Holder

Includes focusing optics for use with a 5 μ L micro cell only for use with the V-730 and V-730BIO.



5 μ L Micro Cell



EMC-759

TCH-703 | 8-Position Micro Turret Cell Holder

Eight 4 μ L cells arranged on a disc, which can be manually selected for fast and accurate measurement of multiple samples



8-Position Micro Turret Cell (P/N: 6916-4822A)



TCH-703

Optical Fiber Units

FAV-750 | Optical Fiber Unit (UV-Visible)

Optical fiber accessories with external detector, enable the measurement of bulky samples that cannot be placed in the sample compartment or that are in special environments.



FAV-750

FAN-751 | Optical Fiber Unit (UV-Visible/NIR)

Optical fiber accessories with external detector, enable the measurement of bulky samples that cannot be placed in the sample compartment or that are in special environments.

**Wavelength range: 250 – 800 nm (FAV-750), 250 – 2000 nm (FAN-751).*

**Optical fiber, optical fiber ports, and external sample compartment are optional.*

FAP-754 | Optical Fiber Unit

Used for measurement of external samples using fiber probes and the internal detector of the spectrophotometer.

**The optical fiber and optical fiber port must be specified separately as below.*



FAP-754

Fiber Connection Port

- Bundle type for FAV-750, FAN-751 and FAP-754
- FC connector type for FAV-750, FAN-751 and FAP-754
- SMA connector type for FAV-750, FAN-751 and FAP-754

ELM-912 | External Light Source Interface

Used to introduce light from an external light source into the spectrophotometer. It can be used for evaluation of the spectral characteristics or intensity of external light sources.

** A calibrated reference source is required for spectral correction of a measured spectrum.*

** The optical fiber must be ordered separately.*



ELM-912

used only with V-730 **V-730**

used only with V-730BIO **V-730BIO**

used only with V-750 **V-750**

used only with V-760 **V-760**

used only with V-770 **V-770**

used only with V-780 **V-780**

compatible with all V-700 Series instruments **V-700**

Integrating Spheres

- used only with V-730 V-730
- used only with V-730BIO V-730BIO
- used only with V-750 V-750
- used only with V-760 V-760
- used only with V-770 V-770
- used only with V-780 V-780
- compatible with all V-700 Series instruments V-700

ISV-922/ISN-923/ISN-901i | Integrating Sphere, 60 mm diam.

Specifications

Model Name	ISV-922	ISN-923	ISN-901i
Instrument	V-750/760 ● ●	V-770 ●	V-780 ●
Inside Diameter of Integrating Sphere	60 mm diam.		
Minimum Sample Size (Reflectance)	20 (H) x 20 (W) x 0.5 (t) mm		
Maximum Sample Size (Reflectance)	65 (H) x 50 (W) x 25 (t) mm		
Sample Cell (Transmittance)	Rectangular cell 5, 10, 20, 30 and 50 mm path length		
Reference Cell (Transmittance)	Rectangular cell 5, 10 and 20 mm path length Reference cell block is optional.		
Wavelength Range	200-870nm	200-2500nm	200-1600nm
Incident Angle to Reflection Surface	0°, approx. 5°		

Optional Holders

PSH-002 | Powder Sample Holder

For diffuse reflectance measurements of powder samples. Sample: 16 mm dia., thickness: 0.5-6 mm

PSH-003 | Powder Sample Holder

For diffuse reflectance measurements of powder samples. Sample: 5 mm dia., thickness: 0.5-3 mm
*When using the PSH-003, Beam Focus Attachment for Reflectance Measurement is required.

ILV-924/ILN-925/ILN-902i | Integrating Sphere, 150 mm diam.

Specifications

Model	ILV-924	ILN-925	ILN-902i
Instrument	V-750/760 ● ●	V-770 ●	V-780 ●
Inside Diameter of Integrating Sphere	150 mm diam.		
Minimum Sample Size (Reflectance)	20 (H) x 20 (W) x 0.5 (t) mm		
Maximum Sample Size (Reflectance)	100 (H) x 50 (W) x 30 (t) mm		
Sample Cell (Transmittance)	Rectangular cell 5, 10, 20, 30 and 50 mm path length		
Reference Cell (Transmittance)	Rectangular cell 5, 10, 20 mm path length. Reference cell block is optional.		
Wavelength Range	220-850nm	220-2200nm	220-1600nm
Incident Angle to Reflection Surface	approx. 5°		

Optional Holders

PSH-002 | Powder Sample Holder

For diffuse reflectance measurements of powder samples. Sample: 16 mm dia., thickness: 0.5-6 mm

SSH-507 | Solid Sample Holder

For diffuse transmittance measurements of solid samples. Minimum sample size: 20(H) x 20(W) x 0.5(t) mm, Maximum sample size: 70(H) x 30(W) x 40(t) mm

IJV-726/IJN-727/IJN-904i | Dedicated Gemstone Integrating Sphere

Specifications

Model	IJV-726	IJN-727	IJN-904i
Instrument	V-750/760 ● ●	V-770 ●	V-780 ●
Inside Diameter of Integrating Sphere	60 mm diam.		
Minimum Sample Size	2 mm diam. (Transmittance/Reflectance)		
Maximum Sample Size (Transmittance)	10 mm diam.		
Maximum Sample Size (Reflectance)	30 mm diam.		
Wavelength Range	220-850nm	220-2000nm	220-1600nm



ISV-922



PSH-002



ILV-924



IJN-727

PIV-756/PIN-757/PIN-903i | Horizontal Sampling Integrating Sphere

Specifications

Model	PIV-756	PIN-757	PIN-903i
Instrument	V-750/760 ● ●	V-770 ●	V-780 ●
Inside Diameter of Integrating Sphere	60 mm diam.		
Maximum Sample Size (Reflectance)	30 x 30 x 10 (t) mm		
Reflectance Measurement Adaptor	20 mm diam. x 2 mm (no window required)		
Minimum Sample Size (Transmittance)	3 mm diam. x 0.5 (T) mm		
Maximum Sample Size (Reflectance)	50(H) x 50(W) x 2(T) mm		
Wavelength Range	250-800nm	250-2000nm	250-1600nm



PIN-757

SIV-767/SIN-768 | Integrating Sphere with Stirrer

Specifications

Model	SIV-767	SIN-768
Instrument	V-750/760 ● ●	V-770 ●
Inside Diameter of Integrating Sphere	60 mm diam.	
Sample Cell (Transmittance)	Rectangular cell 5, 10, 20, 30 and 50 mm path length	
Reference Cell (Transmittance)	Rectangular cell 5, 10, 20 mm path length. Reference cell block is optional.	
Wavelength Range	250-800nm	250-2500nm
Incident Angle to Reflection Surface	approx. 5°	



SIV-767

Optional Holders

RLH-603 | Reference Rectangular Cell Holder

Required for the reference side when performing diffuse transmittance measurements of turbid liquid samples. 5, 10, and 20 mm pathlength rectangular cells can be used with this cell holder.

Thermostatted Cell Holder

Allows temperature-controlled diffuse reflectance and transmittance measurements using a 10x10 mm rectangular cell with a temperature range of 10 to 90°C. A thermostatted water circulator is required.

HISV-728/HISN-729 | Portable Integrating Sphere

Specifications

Model	HISV-728	HISN-729
Instrument	V-750/760 ● ●	V-770 ●
Inside Diameter of Integrating Sphere	60 mm diam.	
Window Size	25 mm diam.	
Wavelength Range	250-800nm	250-2000nm



HISV-728

Optional Accessories

OFV-624/625 | Optical Fiber for HISV-728

Wavelength range: 250-800 nm, Length: 1 m (OFV-624), 2 m (OFV-625)

OFN-626/627 | Optical Fiber for HISN-729

Wavelength range: 250-2000 nm, Length: 1 m (OFN-626), 2 m (OFN-627)

Absolute Reflectance

ARV-913/ARN-914/ARN-915i | Absolute Reflectance Measurement (Manual Synchronous Type)

The ARV and ARN accessories are used for absolute reflectance measurements with manual, synchronous movement of the sample stage and detector. The angle of incident of the sample and the detector positions are moved simultaneously, the absolute reflectance of the sample can be measured at varied incident angles.

ARSV-916/ARSN-917/ARSN-918i | Absolute Reflectance Measurement (Manual Asynchronous Type)

The ARSV and ARSN are used for manual asynchronous movement of the sample stage and detector to obtain independent absolute reflectance and transmittance spectra. Optional polarizers can be used to evaluate the properties of the sample with polarized light.

ARMV-919/ARMN-920/ARMN-921i | Automated Absolute Reflectance Measurement Accessory

The ARMV and ARMN automated absolute reflectance measurement. An integrating sphere also allows measurement of the relative reflectance of a diffusely reflecting sample. Since the angles of the sample stage and the detector can be changed independently, the absolute reflectance and transmittance can be measured with varied angles of incidence. A software controlled polarizer is included for evaluation of the polarization properties of a sample. In addition to S and P polarizations, N polarization obtains the same measurement results as non-polarized light.

*Please note that ARMV-919, ARMN-920 and ARMN-921i cannot work with iRM-1000.

Specifications

Model	ARV-913	ARN-914	ARN-915i	ARSV-916	ARSN-917	ARSN-918i	ARMV-919	ARMN-920	ARMN-921i
Instrument	V-750/760	V-770	V-780	V-750/760	V-770	V-780	V-750/760	V-770	V-780
Wavelength Range	250-850 nm	250-2000 nm	250-1600 nm	250-850 nm	250-2000 nm	250-1600 nm	250-850 nm	250-2000 nm	250-1600 nm
Movement of Sample Stage and Detector	Synchronous			Asynchronous					
Control of Sample Stage and Detector	Manual						Automated		
Measurement Mode	Absolute reflectance, Relative reflectance			Absolute reflectance, Relative reflectance, Transmittance					
Integrating Sphere	60 mm diam.								
Incidence Angle	Absolute reflectance mode: 5° to 60°, Relative reflectance mode: Vertical incidence								
	Transmittance mode: 0° to 60°								
Angle Setting	2.5° step (manual)			Sample stage: 0.1° step (manual) Detector stage: 1° step (manual)			0.1° step automatic		
Sample Size	Absolute reflectance mode: Min. 20 (H) x 20 (W) x 1 (t) mm								
	Absolute reflectance mode: Max. 70 (H) x 100 (W) x 10 (t) mm								
	Relative reflectance mode: Min. 20 (H) x 20 (W) x 0.5 (t) mm								
	Relative reflectance mode: Max. 70 (H) x 100 (W) x 10 (t) mm								
Accuracy	±1.5% at incidence angle of 6°								
100% Line Flatness	Within ±1%								
Polarizer	Option (ARG-476 Polarizer)						Standard		
Standard Software	N/A						Absolute reflectance spectral measurement, Interval analysis		

Optional Accessories

SSH-508 | Solid Sample Holder

Used at the entrance to the detector for diffuse transmittance measurement.

PDU-926 | Phase Difference Measurement Unit

Uses an angle selective analyzer to obtain reflectance and transmittance phase difference measurements. The VWAP-794 Phase Difference Measurement program is required. Wavelength range: 250 – 850 nm (ARV-913/ARSV-916/ARV-919), 250 - 2000 nm (ARV-914/ARSV-917/ARV-920), 250 – 1600 nm (ARV-915i/ARSV-918i/ARV-921i). Polarization rotation angle: 0-90°.

Wide Incident Angle Sample Holder

Widens the angle of incidence up to 85° (minimum angle is 0°). Minimum sample size: 30(H) x 60(W) x 1(t) mm (ARV/ARN), 30(H) x 30(W) x 1(t) mm (ARSV/ARSN/ARMV/ARMN), Maximum sample size: 70(H) x 100(W) x 10(t) mm.



ARV-913



ARMV-919

Specular Reflectance

SLM-907/SLM-908 | Spectacular Reflectance Accessory

Measure the relative specular reflectance of a sample using an aluminum-deposited plane mirror as a reference. The SLM can be used to measure the reflectance and thickness of metal-deposited films. The SLM-908 can measure larger samples such as 6 inch silicon wafers.

Specifications

Model	SLM-907	SLM-908
Angle of Incidence	Approx. 5° fixed	
Maximum Sample Size	100 x 120 mm	150 mm dia. (Accommodating 6-inch Wafer)
Minimum Sample Size	10 x 10 mm	
Beam Port Diameter	7 mm diam. (2 mm, 4 mm diam. options)	7 x 7 mm
Reflection Reference	Aluminum-deposited plane mirror (standard)	
Wavelength Range	V-730	250-1000 nm
	V-750/760	200-870 nm
	V-770	200-2500 nm
	V-780	200-1600 nm
Sample Chamber Lid	Standard	

Optional Accessories

MSK-001 | Sample Stage with Φ 2 mm Port

Minimum sample size: 3x3 mm, Maximum sample size: 50x50 mm

MSK-002 | Sample Stage with Φ 4 mm Port

Minimum sample size: 5x5 mm, Maximum sample size: 50x50 mm

Polarizer, Depolarization Plate

GPH-506 | Polarizer

Linear polarizer for the incident beam entering the sample compartment. The plane of polarization can be set at 0° or 90°. Spectral range from 215 to 2,300 nm.

DPL-515 | Depolarization Plate

Ensures that the incident light is non-polarized. Non-polarization is obtained with the rotation angle set to 45°. Spectral range is from 350 to 2,500.



SLM-907



SLM-908



GPH-506



DPL-515

- used only with V-730 V-730
- used only with V-730BIO V-730BIO
- used only with V-750 V-750
- used only with V-760 V-760
- used only with V-770 V-770
- used only with V-780 V-780
- compatible with all V-700 Series instruments V-700

Autosampler, Sippers & Flow Cells

- used only with V-730 V-730
- used only with V-730BIO V-730BIO
- used only with V-750 V-750
- used only with V-760 V-760
- used only with V-770 V-770
- used only with V-780 V-780
- compatible with all V-700 Series instruments V-700

ASU-800 | Autosampler Unit

Automates the measurement of multiple liquid samples when used with a sipper or syringe pump. Various optional racks can be used with a range of test tubes, vials or microplates.

Dust Cover

ASU-800 protective cover.

Specifications

Compatible Pump	Type
NQF-781	Vacuum Sipper
NQF-783	Vacuum Sipper with Long-Path Flow Cell
NPF-782	Peristaltic Sipper
ASP-849	Syringe Pump

Option Racks

	Rack	Sample	Max No. of Samples
SRA-811	15 mm O.D. Test Tube	10 mL	100
SRA-812	13 mm O.D. Test Tube	7 mL	100
SRA-813	12 mm O.D. Test Tube	5 mL	150
SRA-814	10 mm O.D. Test Tube	3 mL	150
SRA-816	Micro Plate Rack	1 mL	196
SRA-818	Vial Rack	1.5 mL	120



ASU-800



Dust Cover



ASP-849

ASP-849 | Syringe Pump

Used with the ASU-800 and SFC-712 flow cell holder. The syringe pump is suitable for measurement of small sample volumes. The unit includes a 2.5 mL syringe (1, 5, and 10 mL are optional).

Specifications

Reproducibility of Volume Delivery	Within ±1%
Syringe Capacity	2.5 mL (1, 5, 10 mL options)

NQF-781 | Vacuum Sipper

Vacuum sipper for fast measurement, the sample cannot be recovered. Path length 10 mm.

NQF-783 | Vacuum Sipper with Long-Path Flow Cell

Vacuum sipper for fast measurement, the sample cannot be recovered. Path length 50 mm.

NPF-782 | Peristaltic Sipper

Peristaltic sipper with sample recovery. Path length 10mm, can also be used with standard 10x10 mm cuvette by switching-out the flow cell.

Specifications

	NQF-781	NPF-782	NQF-783
Light Path Length	10 mm		50 mm
Cell Capacity	Approx. 50 µL		Approx. 1.4 mL
Cell Material	Quartz		
Carryover	Less than 1%		
Minimum Sample Requirement	0.7 mL with low-viscosity samples		2.4 mL with low-viscosity samples
Processing capacity 450 samples/hr			
Wavelength Range	220 - 900 nm (V-730/750/760)		
	220 - 2200 nm (V-770)		
	220 - 1600 nm (V-780)		



NQF-781



NPF-782

SFC-712 | Flow Cell Holder

Flow cell holder, select from 5 or 10 mm pathlength flow cells with a volume of 50 and 100 µL, respectively.

LFC-713 | Long Path Flow Cell Holder

Flow cell holder, select from 30, 50, and 100 mm pathlength flow cells with a volume of 0.6, 1, and 2 mL, respectively.

MFC-714 | Micro Flow Cell Holder

Stainless-steel flow cell with 10 mm pathlength and 20 µL volume.

FIC-715 | Micro Flow Cell Holder

Teflon flow cell with 10 mm pathlength and 20 µL volume.

AWU-828 | Washing Unit

Automatic washing system for the ASU-800 autosampler. For use with NQF-781, NQF-783 and NPF-782 sippers.



SFC-712



LFC-713



MFC-714



FIC-715



AWU-828

Automated Systems with ASU-800 and V-730



ASU-800 with NPF-782 Peristaltic Sipper



ASU-800 with ASP-849 Syringe Pump and SFC-712 Micro Flow Cell



ASU-800 with NQF-781 Vacuum Sipper

Spectra Manager™ Software Suite

Instrument Control

Spectra Manager™ includes control of a wide range of instruments with easy to edit parameter files and data processing functions. Data acquired from the instrument is automatically loaded into an analysis program to free up the PC and control software to acquire further data during post-acquisition processing. Each instrument also has its own range of dedicated applications for analysis, instrument diagnostics and validation.

Flexible Display Features

User-friendly features include flexible customization of the GUI, user-adaptable toolbars and sophisticated handling of spectral and time course data in two- and three-dimensions.

Data Processing and Spectral Analysis

View and process the different types of measurement data (UV-Visible/NIR, FTIR, Fluorescence, CD) in a single window, using a comprehensive range of data processing functions. Features include instrument specific corrections and analysis, arithmetic operations, derivatives, peak detection, smoothing, and baseline correction.

Wide Range of Standard and Optional Programs

Spectra Manager has a diverse range of instrument specific applications for data analysis and interpretation.

Reporting

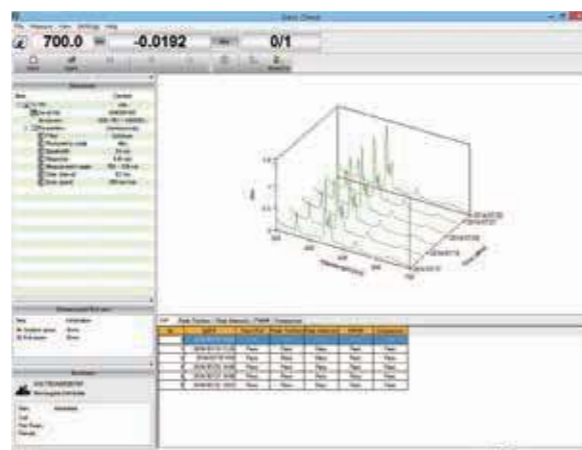
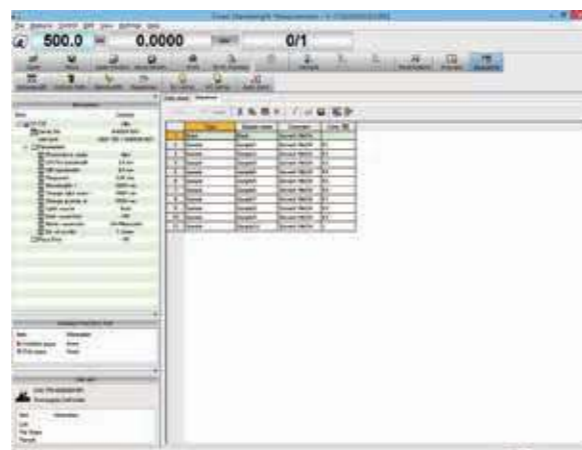
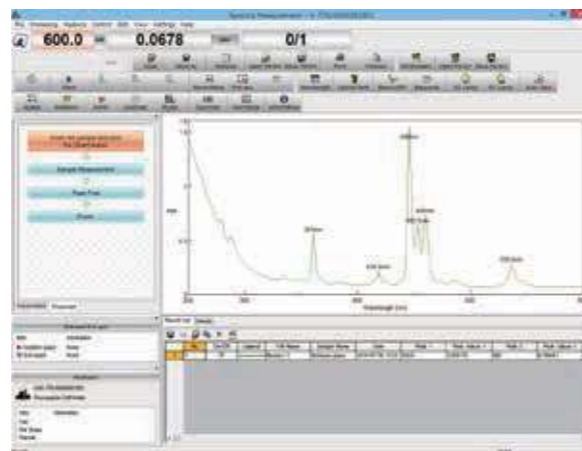
JASCO Canvas allows the creation of bespoke layout templates of spectral data and results to meet individual reporting requirements.

Macro Command Program

This Macro Command Program can be used to develop user-designed applications for individual experimental set-up and measurement, including instrument control, data acquisition, post-acquisition data processing and reporting.

Regulatory Compliance with Spectra Manager™ CFR

Spectra Manager CFR provides secure access and compliance with 21 CFR Part 11. System access requires a username and password, assigned by the Workgroup Manager. Security levels define access to administrative tools for the installation of instruments and analysis applications, user and workgroup setup, security policies, as well as system and application history logs. Three levels of electronic signatures are provided, including creation, review, and approval. An audit trail, which is overseen by Windows security, monitors the transaction log for any changes to parameters or data files.



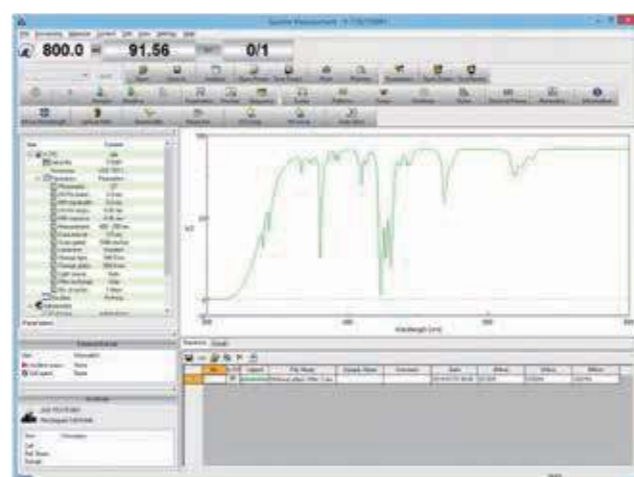
A SINGLE PLATFORM FOR EVERY INSTRUMENT.

JASCO is the only manufacturer to have developed a single, cross-platform 64-bit Windows software package for operating a wide range of spectroscopic instrumentation. Spectra Manager™ is a comprehensive lab companion for designing experimental measurement and processing data, eliminating the need to learn multiple software programs and allowing data from more than one instrument to be displayed and analyzed together on the same computer.

Standard Measurement Programs

Spectra Measurement

Measures the absorbance, transmittance, or reflectance spectrum of a sample. Sequential measurements can also be made on multiple samples, each of which can be assigned different measurement parameters. A customizable flowchart can be used to automate the flow of measurement, data processing, saving and reporting functions.



Quantitative Measurement

Create a calibration curve using the absorbances of standards with known concentrations, and then use the absorbance for samples with unknown concentrations to interpolate the concentration from the calibration curve. Several quantitation methods are included. The calibration curve can be constructed using linear or polynomial fitting with linearity criteria and 'goodness of fit' statistics.

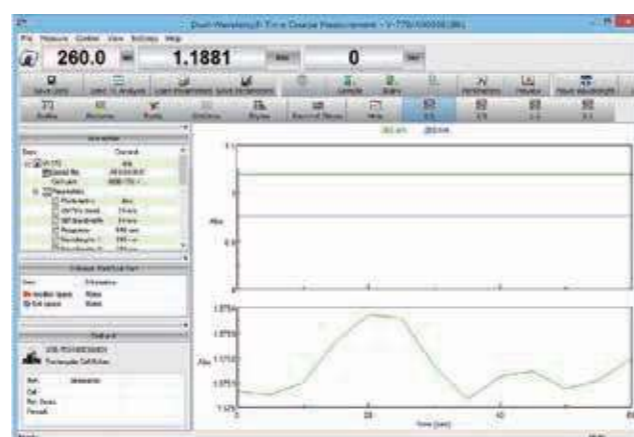


Time Course Measurement

Measure changes in absorbance, transmittance, or reflectance over a specified time at a fixed wavelength. This can be used for kinetics measurement or stability testing.

Dual-Wavelength Time Course Measurement

Measure changes in absorbance, transmittance, or reflectance over a specified time at up to two fixed wavelengths. This can be used for kinetics measurement or stability testing.



Fixed Wavelength Measurement

Measure the absorbance, transmittance, or reflectance of a sample at a fixed wavelength. Up to twenty different wavelengths can be used for measurement.

Abs/%T Meter

The photometric value in absorbance or transmittance is displayed in analog, digital, or graphical modes.

Parallel Kinetics Measurement

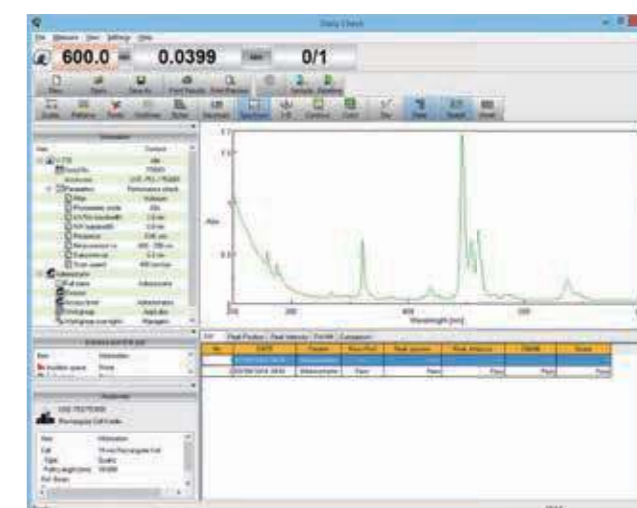
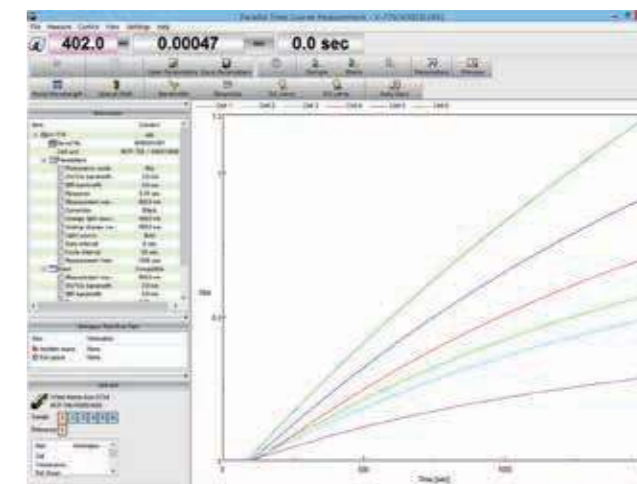
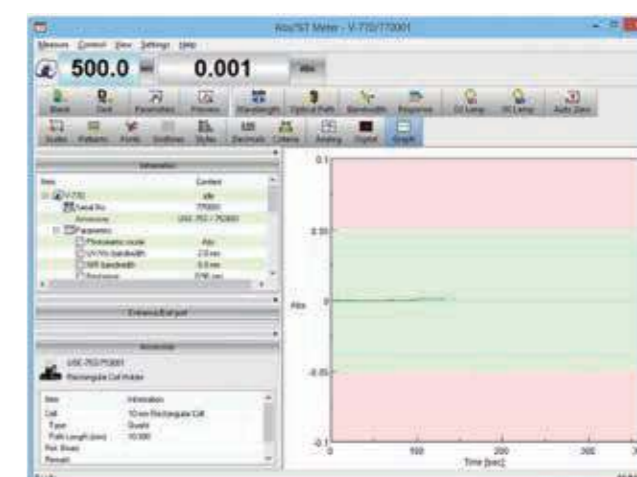
Measures changes in the absorbance, transmittance, or reflectance at a fixed wavelength for a sample(s) over a specified time period, and is designed for use with a multi-cell changer.

Validation

Check the functional performance of a UV-Visible/NIR spectrophotometer using a variety of inspection methods, including those required by regulatory compliance. These include wavelength accuracy and repeatability, photometric accuracy and repeatability, resolution, stray light, noise level, and baseline stability and flatness.

Daily Check

This simple performance check of the spectrophotometer can be made regularly by measuring the absorbance spectrum of a holmium standard supplied with the instrument. The statistics are accumulated over a period of time to monitor and ensure continuous optimal operation.



Optional Programs

Bio Applications

VWTP-959 | Temperature Control Measurement and DNA Melting Analysis

Temperature Control Measurement Program performs thermal melting measurement by monitoring changes in the photometric value of samples at a fixed wavelength with change in temperature. The melting temperature can be calculated from the measured temperature-dependent data using the Melting Temperature Calculation program. **A Peltier thermostatted cell holders is required.*

The DNA Melting Analysis Program estimates the melting temperature of a protein or nucleic acid based on temperature-dependent data using either the Temperature Control Measurement or Temperature Interval Scan Measurement programs. The melting temperature can be calculated using any of three methods: 2nd derivative, Least squares, and One-point.

VWPN-952 | Protein/Nucleic Acid Measurement

Measure spectra or fixed wavelength of proteins and/or nucleic acids and calculate the sample concentration. Quantitation can be made using one of six fixed methods or a user-defined method.

VWKN-722 | Advanced Kinetic Analysis

Calculate initial velocity, v , of enzymatic reactions based on time-course data, and velocity parameters (maximum velocity, V_{max} , Michaelis-Menten constant, K_m , and the Hill coefficient, n) based on a plot of the initial velocity, v , versus the substrate concentration [S]. The enzymatic activity can also be determined.

VRBP-790 | Bio Package

The Bio Package for Intelligent Remote Module and Spectra Manager™ versions includes: *Protein Nucleic Acid Measurement, Kinetics Analysis, Temperature Control Measurement, and DNA Melting Analysis.*

Interval Measurement

VWIS-957 | Interval Scan Measurement

Measure changes with time for sample absorbance at up to four wavelengths, as well as for a selected wavelength range. The measurement time interval can also be set in either minutes or seconds for up to 24 days of continuous measurement (maximum time interval is 1 day). Up to 60,000 spectra can be saved in a single interval scan measurement file.

VWTS-958 | Temperature Interval Scan Measurement

Measure spectral scans at selected temperature intervals. Temperature-dependent data can also be monitored at up to four wavelengths with a temperature ramp range from 0.1 to 10° C/min, depending on the type of temperature controlled cell holder. The sample temperature can be monitored and/or controlled either using the cell holder sensor or a temperature probe inserted into the cell. Stirring may be available depending on the cell holder. **A Peltier thermostatted cell holder is required.*

Reflectance Measurement

VWAM-968 | Absolute Reflectance Spectra Measurement

Measure reflectance and transmittance spectra by setting the incidence and detection angles. For reflectance measurements, the incident angle can be set from 5 to 85° and from 0 to 85° for transmittance measurements. S- (0°), P- (90°), or N- (45°) polarization can be set for the incident light.

**This program is included in ARMV-919, ARMN-920 and ARMN-921i as standard.*

VWAS-969 | Absolute Reflectance with Variable Incident Angle Measurement

Measures the angular dependence of the reflectance and transmittance spectra by setting the incident and detection angles, for up to 20 wavelengths. For reflectance measurements, the incident angle can be set from 5 to 85° and from 0 to 85° for transmittance measurements. S- (0°), P- (90°), or N- (45°) polarization can be set for the incident light.

**Absolute Reflectance Measurement Unit is required.*

VWAP-970 | Phase Difference Spectra Measurement

Automatically measure transmittance and reflectance phase difference spectra with multiple incident angles using an automated absolute measurement accessory. The spectrum can be measured by rotation of either polarizer or analyzer.

**This program is included in PDU-926 as standard.*

Material Analysis

VWSD-961 | Spectrum Diagnosis

Perform data processing with pass/fail evaluation on a measured spectrum based on photometric values at a specified wavelength, full width at half maximum, peak photometric values, peak wavelengths etc. Sequential measurements can also be carried out on multiples samples, each of which can be assigned different sample measurement parameters.

VWML-791 | Multi-Layer Film Thickness Analysis

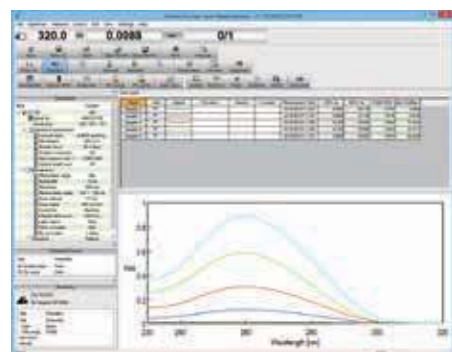
Use a reflectance spectra and select a multilayer model to calculate the refractive index (n), extinction coefficient (k), and layer thickness (d) of unknown layer(s) using a least squares method. Standard libraries are included for metals, semiconductors and insulators. The user can also create their own library. **Absolute Reflectance Measurement Unit is required.*

VWBG-773 | Band Gap Calculation

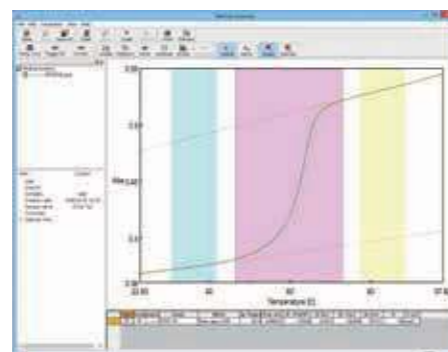
Calculate the band gap of a semiconductor sample from its spectrum. The following calculation methods can be selected:

- Direct transition: allowed
- Direct transition: forbidden
- Indirect transition: allowed
- Indirect transition: forbidden

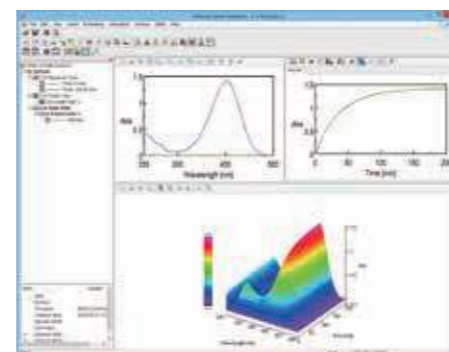
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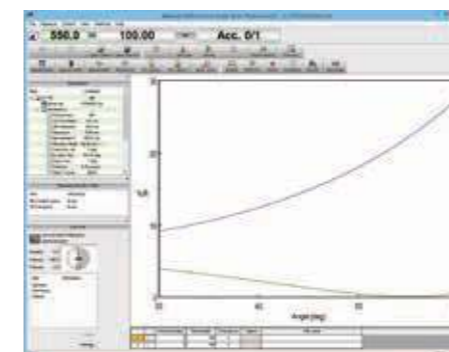
Protein/Nucleic Acid Measurement



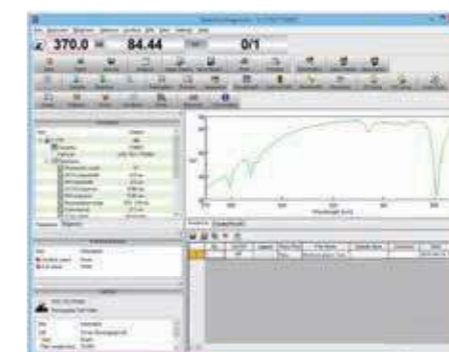
Melting Analysis



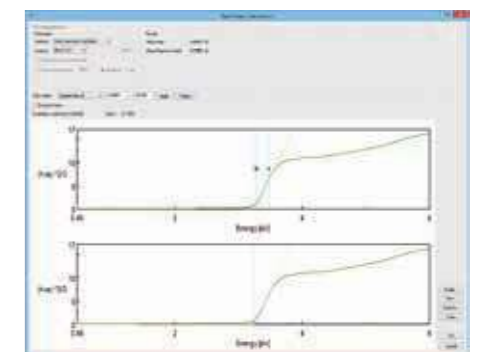
Interval Data Analysis



Absolute Reflectance Angle Measurement



Spectra Diagnosis



Band Gap Calculation

Optional Programs

Quantitation and Chemometrics

VWQM-978 | Spectrum Quantitative Measurement

Measure the spectrum of a sample and perform quantitation using either the absorbance at a specified wavelength, or the peak absorbance for a standard sample with maximum concentration. The quantitation method can be selected from the following: no base (1-wavelength quantitative analysis), one-point base (2-wavelength quantitative analysis), or two-point base (3-wavelength quantitative analysis).

VWSQ-776 | Spectral Quantitative

This program can create calibration curves for multiple components, and can perform quantitative analysis on samples having multiple components simultaneously.

VWCL-954 | CLS Quantitative Measurement

Measure samples and automatically perform a quantitative analysis using the classical least squares (CLS) method. A CLS calibration model must first be created and contain correlation curves for quantifying the normal absorbance of the components to be analyzed.

VWPC-955 | PCR Quantitative Measurement

Measure samples and automatically perform a quantitative analysis using the principle component regression (PCR) method. A PCR calibration model must first be created and contain correlation curves for quantifying the normal absorbance of the components to be analyzed.

VWPL-956 | PLS Quantitative Measurement

Measure samples and automatically perform a quantitative analysis using the partial least squares (PLS) method. A PLS calibration model must first be created and contain correlation curves for quantifying the normal absorbance of the components to be analyzed.

VWPA-785 | PCA Analysis

This program can create the PCA model from the spectrum of a known substance and can predict the classification of an unknown sample from the spectrum by using the PCA model.

Color Analysis

VWCD-960 | Color Evaluation – Color Diagnosis

Comprehensive color analysis software with calculations for several different color standards including ASTM, ISO and JIS. Color and color differences are calculated from an absorbance spectrum measured from 360-830 nm. Chromaticity coordinates are plotted in the selected color system. Comparison can also be made to previously measured color spectra.

VWCM-795 | Computer Color Matching Analysis

Match a spectrum with a target color using a library created with the Computer Color Matching Library program. The Color Matching Library program allows a total of 16 reference color spectra to be registered, edited, deleted, and displayed. All color matching calculation parameters, such as selecting the reference color library, color system, color matching function, standard observer, and light source, can be user defined.

VWAC-974 | ASTM Color Analysis

Calculate the sum of the tristimulus values (X, Y, Z) and optical density from a sample absorbance, reflectance, or transmittance spectrum and obtain the ASTM color. The ASTM color, sum of optical densities, and tristimulus values are all reported. The ASTM color analysis can only be performed in the wavelength range between 380 to 780 nm.

VWSC-975 | Saybolt Color Analysis

Calculate the Saybolt color of a sample spectrum for wavelengths between 380 to 780 nm, according to the XYZ color system described by the International Commission on Illumination (CIE).

VWLU-963 | Luminous Color Measurement

Measure the luminescence spectrum for a sample and calculate its chromaticity using the Luminous Color Analysis program, pass/fail criteria can also be included. To correct for the spectrophotometer's instrument characteristics (i.e. wavelength-dependent grating efficiencies and detector sensitivities), spectral correction can be made using a standard light source. **not for use with the V-730. External light source interface and calibrated reference source are required.*

Solar Measurement and Sun Protection

VWST-964 | Solar Transmittance/Reflectance Measurement

Measure the spectral transmittance and reflectance of a sample and calculates the solar reflectance, transmittance, and absorbance, as well as the light transmittance, reflectance etc. **V-770 only. Integrating sphere is required.*

VWSP-966 | SPF/PA Calculation

Using an integrating sphere, this application is used for evaluating the criteria the sun protection factor (SPF) and PA for sunscreens and cosmetics **requires an integrating sphere and SPF cell*

VWUP-967 | UPF Measurement

Used to measure the transmittance of a sample to calculate the ultraviolet protection factor (UPF), UPF rating, UVA transmittance and blocking, and UVB transmittance and blocking according to a variety of standards. **cannot be used with a V-730, requires an integrating sphere*

VWSE-798 | UV Shield Factor Calculation

Calculate the UV shield factor for a specified wavelength range from a transmittance, reflectance, or absorbance spectrum. A maximum of five wavelength ranges can be specified.

Haze and Turbidity Measurement

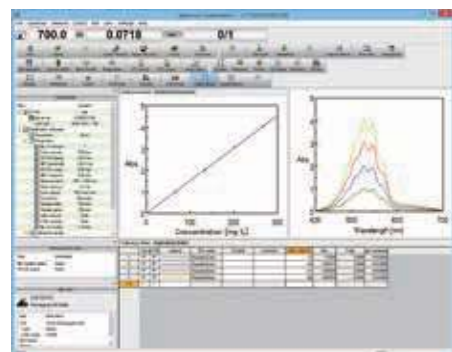
VWWQ-953 | Chromaticity/Turbidity Measurement

Measure the absorbance or transmittance of a sample in order to determine its chromaticity or turbidity. The turbidity can also be measured using an integrating sphere in order to evaluate both transmitted and scattered light.

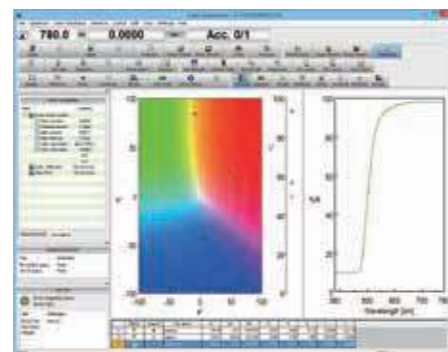
VWHZ-965 | Sample Haze Calculation

Using an integrating sphere, the measured total luminous transmittance and diffuse transmittance spectra are used to calculate haze. Criteria can be specified to perform a pass/fail evaluation. **cannot be used with a V-730, requires an 150 mm dia. integrating sphere*

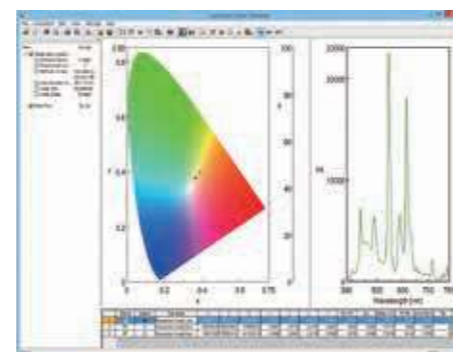
compatible with 21 CFR Part 11 **CFR**



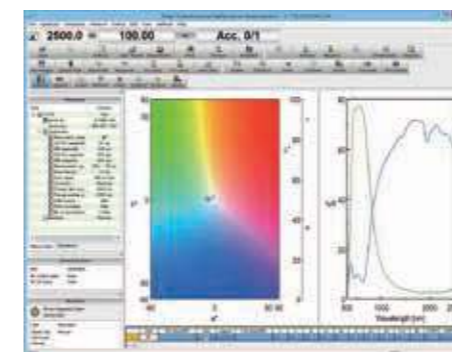
Spectrum Quantitation



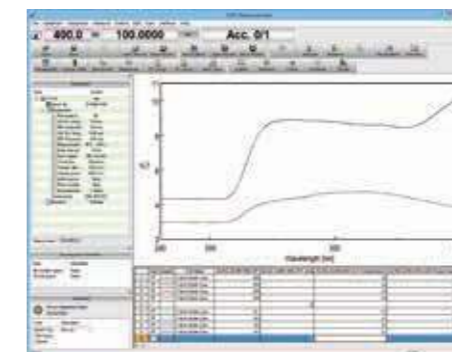
Color Evaluation



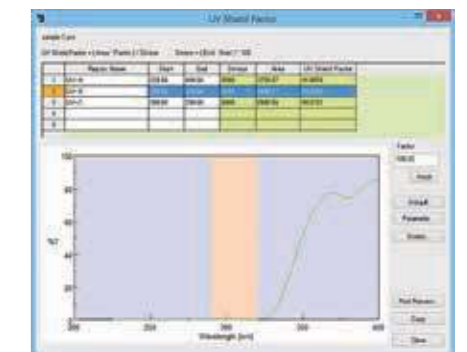
Luminous Color Measurement



Solar Transmittance/Reflectance Measurement



UPF Measurement

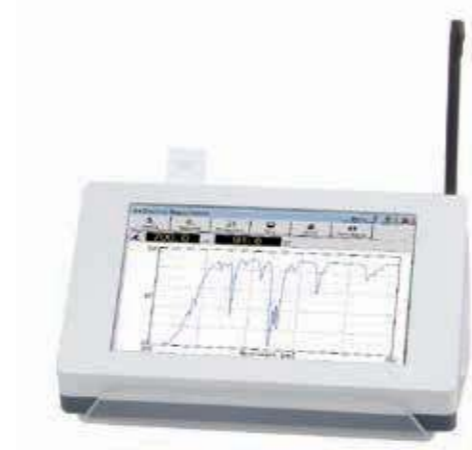


UV Shield Factor Calculation

iRM-1000 Intelligent Remote Module

The **iRM-1000 intelligent remote module** incorporates a color LCD touch screen for simple operation and data measurement. The iRM-1000 conveniently guides the operator through everything from data acquisition to data processing and reporting. Results can be saved to a USB memory for further processing using Spectra Analysis on a PC or laptop.

- High quality color LCD display
- Operation using finger or Touch Pen
- Spectra, fixed wavelength and quantitative analysis
- Validation
- Print to a USB printer
- Save data to a USB memory



iRM-1000



Easy Data Transfer to a PC



Touch-Sensitive Screen

Standard Measurement Programs for iRM

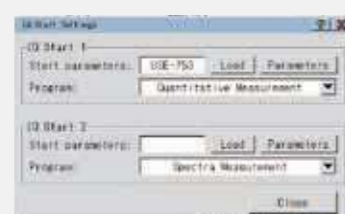
- Spectra Measurement
- Time Course Measurement
- Quantitative Analysis
- Fixed Wavelength Measurement
- Abs/%T Meter
- Macro Command
- Validation
- Daily Check

Standard Analysis Programs for iRM

- Spectra Analysis
- Enzymatic Reaction Rate Calculation
- Color Analysis
- Film thickness

Optional Programs for the iRM-1000

- VRBP-790 | Bio Package**
Includes: Protein Nucleic Acid Measurement, Kinetics Analysis, Temperature Control Measurement, and DNA Melting Analysis.



IQ Accessory and IQ Start

Includes both IQ Accessory for automatic accessory recognition and IQ Start for quick start of pre-registered parameter files for routine measurements.

Specifications

Model	V-730	V-750	V-760	V-770	V-780
Optical System	Rowland off-circle arrangement Single monochromator Double beam type	Czerny-Turner mount Single monochromator Fully symmetrical double beam type	Czerny-Turner mount Double monochromator Fully symmetrical double beam type	Czerny-Turner mount Single monochromator Fully symmetrical double beam type	Czerny-Turner mount Single monochromator Fully symmetrical double beam type
Light Source	Halogen lamp, Deuterium lamp (Light source exchange wavelength: Any wavelength between 330 and 350 nm can be selected)				
Detector	Silicon photodiode	Photomultiplier tube		Photomultiplier tube Peltier cooled PbS	Photomultiplier tube Peltier cooled InGaAs photodiode
Wavelength Range	190 to 1100 nm	190 to 900 nm	187 to 900 nm	190 to 2700 nm (3200 nm, option)	190 to 1600 nm
Wavelength Accuracy	±0.2 nm (at 656.1 nm)	±0.2 nm (at 656.1 nm)	±0.1 nm (at 656.1 nm)	±0.3 nm (at 656.1 nm) ±1.5 nm (at 1312.2 nm)	±0.3 nm (at 656.1 nm) ±1.0 nm (at 1312.2 nm)
Wavelength Repeatability	±0.1 nm	±0.05 nm	±0.05 nm	±0.05 nm (UV-Vis) ±0.2 nm (NIR)	±0.05 nm (UV-Vis) ±0.1 nm (NIR)
Scanning Speed	10 to 8000 nm/min	10 to 4000 nm/min (8000 nm/min in preview mode)			
Slew Speed	24000 nm/min	12000 nm/min		UV-Vis: 12000 nm/min NIR: 48000 nm/min	UV-Vis: 12000 nm/min NIR: 24000 nm/min
Spectral Bandwidth (SBW) L: Low Stray Light Mode M: Micro Cell Mode	1.0 nm fixed	0.1, 0.2, 0.5, 1, 2, 5, 10 nm L2, L5, L10 nm M1, M2 nm		UV-Vis: 0.1, 0.2, 0.5, 1, 2, 5, 10 nm L2, L5, L10 nm M1, M2 nm NIR: 0.4, 0.8, 2, 4, 8, 20, 40 nm L8, L20, L40 nm M4, M8 nm	UV-Vis: 0.1, 0.2, 0.5, 1, 2, 5, 10 nm L2, L5, L10 nm M1, M2 nm NIR: 0.2, 0.4, 1, 2, 4, 10, 20 nm L4, L10, L20 nm M2, M4 nm
Photometric Range	-3 to 3 Abs	-4 to 4 Abs	-4 to 6 Abs	UV-Vis: -4 to 4 Abs NIR: -3 to 3 Abs	UV-Vis: -4 to 4 Abs NIR: -3 to 3 Abs
Photometric Accuracy	±0.0015 Abs (0 to 0.5 Abs) ±0.0025 Abs (0.5 to 1 Abs) ±0.3 %T Tested with NIST SRM 930				
RMS Noise *1	0.00004 Abs	0.00003 Abs	0.00003 Abs	0.00003 Abs	0.00003 Abs
Baseline Flatness	±0.0005 Abs *2	±0.0002 Abs *3	±0.0003 Abs *4	±0.0002 Abs *5	±0.0002 Abs *6
Baseline Stability	±0.0004 Abs/hour *7	±0.0003 Abs/hour *8			
Stray Light	1% (198 nm KCl 12 g/L) 0.02% (220 nm NaI 10 g/L) 0.02% (340 nm NaNO2 50 g/L) 0.02% (370 nm NaNO2 50 g/L) Aqueous solution, SBW: 1.0 nm	1% (198 nm KCl 12 g/L) 0.005% (220 nm NaI 10 g/L) 0.005% (340 nm NaNO2 50 g/L) 0.005% (370 nm NaNO2 50 g/L) Aqueous solution, SBW: L2 nm	1% (198 nm KCl 12 g/L) 0.00008% (220 nm NaI 10 g/L) 0.00008% (340 nm NaNO2 50 g/L) 0.00008% (370 nm NaNO2 50 g/L) Aqueous solution, SBW: L2 nm	1% (198 nm KCl 12 g/L) 0.005% (220 nm NaI 10 g/L) 0.005% (340 nm NaNO2 50 g/L) 0.005% (370 nm NaNO2 50 g/L) Aqueous solution, SBW: L2 nm 0.04% (1420 nm: H2O) 0.1% (1690 nm: CH2Br2 50 mm cell) SBW: L8 nm	1% (198 nm KCl 12 g/L) 0.005% (220 nm NaI 10 g/L) 0.005% (340 nm NaNO2 50 g/L) 0.005% (370 nm NaNO2 50 g/L) Aqueous solution, SBW: L2 nm 0.04% (1420 nm: H2O) SBW: L4 nm
Dimensions and Weight	486(W)x441(D)x216(H) mm 15 kg	460(W)x602(D)x268(H) mm 27 kg	460(W)x602(D)x268(H) mm 29 kg	460(W)x602(D)x268(H) mm 29 kg	460(W)x602(D)x268(H) mm 29 kg
Power Requirements	120 VA	150 VA	150 VA	150 VA	150 VA

*1: 0 Abs, wavelength: 500 nm, measurement time: 60 sec, response: medium, SBW:1 nm (V-730), 2 nm (V-750,760,770,780)

*2: Value obtained more than two hours after turning on the light source, when the room temperature is stabilized, wavelength: 200 to 1000 nm, response: Slow and wavelength scanning speed: 400 nm/min with smoothing processing

*3: Value obtained more than an hour after turning on the light source, when the room temperature is stabilized, wavelength: 200 to 850 nm, response: Slow, SBW: 2 nm and wavelength scanning speed: 400 nm/min with smoothing processing

*4: Value obtained more than an hour after turning on the light source, when the room temperature is stabilized, wavelength: 200 to 800 nm, response: Slow, SBW:2nm, wavelength scanning speed: 400 nm/min with smoothing processing

*5: Value obtained more than an hour after turning on the light source, when the room temperature is stabilized, wavelength: 200 to 2500 nm (200 to 850nm: SBW 2 nm, 850 to 2500 nm: SBW8 nm), response: Slow, wavelength scanning speed: 400 nm/min with smoothing processing

*6: Value obtained more than an hour after turning on the light source, when the room temperature is stabilized, wavelength: 200 to 1600 nm (200 to 850nm: SBW 2 nm, 850 to 1600 nm: SBW4 nm), response: Slow, wavelength scanning speed: 400 nm/min with smoothing processing

*7: Value obtained more than two hours after turning on the light source, when the room temperature is stabilized, wavelength: 250 nm, response: slow

*8: Value obtained more than an hour after turning on the light source, when the room temperature is stabilized, wavelength: 250 nm, response: slow and SBW: 2nm

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